

Notice of References Cited	Application/Control No. 10/693,390		Applicant(s)/Patent Under Reexamination SCHINDLER ET AL.	
	Examiner Tai T. Nguyen		Art Unit 2632	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-2002/0175832	11-2002	Mizusawa et al.	340/932.2
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	L	US-			
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NON-PATENT DOCUMENTS

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